

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

**EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.*

1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.

INFORMATION DISCLOSURE CITATION IN AN APPLICATION <i>O I P E</i> SEP 27 2002 U. S. PATENT & TRADEMARK OFFICE 100 PTO-1449			ATTY. DOCKET NO. 50346-027	SERIAL NO. 09/832,181	<i>SAC #6</i>	
			APPLICANT Michael SANDLIN, et al.	10-2-02		
			FILING DATE April 11, 2001	GROUP 1743	<i>1753</i>	
U. S. PATENT DOCUMENTS						
EXAMINER'S INITIALS	PATENT NO.	DATE	NAME	CLASS	SUBCLASS	
<i>jan</i>	5,778,302	07/07/1998	Ivanow	204	298,13	
<i>jan</i>	6,406,600	06/18/2002	Takashima	419	32	
FOREIGN PATENT DOCUMENTS						
EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation <input type="checkbox"/> Yes <input type="checkbox"/> No
<i>jan</i>	2000-282229	10/10/2000	Japanese with English abstract	—	—	
<i>jan</i>	05148631	06/15/1993	European	—	—	
<i>jan</i>	04297572	10/21/1992	European	—	—	
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)						
EXAMINER	DATE CONSIDERED					
<i>Lahey McDonald</i>	<i>11/6/02</i>					

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.